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_	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/955,278	WANG ET AL.	
	Examiner	Art Unit	
	Jacob Meek	2637	

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Class	Subclass	Date	Examiner
375	231,232	12/7/2005	JM
333	18	12/7/2005	JM

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DATE	EXMR
12/7/2005	JM
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